MOSFET, Single N-Channel, POWERTRENCH®

40 V, 10 A, 14 mΩ

General Description

This device has been designed to provide maximum efficiency and thermal performance for synchronous buck converters. The low r_{DS(on)} and gate charge provide excellent switching performance.

Features

- Max $r_{DS(on)} = 14 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 10 \text{ A}$
- Max $r_{DS(on)} = 18 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 8.5 \text{ A}$
- Low Profile 0.8 mm maximum in the new package MicroFET 2 x 2 mm
- Free from halogenated compounds and antimony oxides
- RoHS Compliant

Application

DC–DC Buck Converters

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	40	V
V _{GS}	Gate to Source Voltage	±20	V
Ι _D	Drain Current – Continuous T _A = 25°C (Note 1a)	10	A
	 – Pulsed (Note 3) 	80	
PD	Power dissipation $T_A = 25^{\circ}C$ (Note 1a)	2.4	W
	Power dissipation $T_A = 25^{\circ}C$ (Note 1b)	0.9	
T _{J,} T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1a)	52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	145	

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Shipping [†]
051	FDMA8051L	MicroFET 2x2	3000 Units/ Tape & Reel

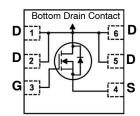
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



ON Semiconductor®

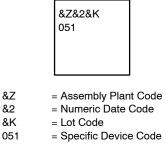
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ELECTRICAL CONNECTION









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ORDERING INFORMATION

See detailed ordering and shipping information on page 1 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

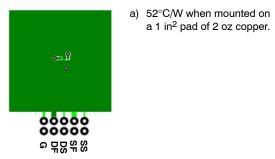
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS	-	•			
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	40			V
$\frac{\Delta {\rm BV}_{\rm DSS}}{\Delta {\rm T}_{\rm J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25°C		22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-to-Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V			100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	V_{GS} = V_{DS} , I_D = 250 μ A	1.0	1.6	3.0	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25° C		-5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 10 A		11	14	mΩ
		V_{GS} = 4.5 V, I _D = 8.5 A		14	18	
		V_{GS} = 10 V, I _D = 10 A, T _J = 125°C		15	19	
9 _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 10 A		35		S
DYNAMIC C	HARACTERISTICS					
C _{iss}	Input Capacitance	V_{DS} = 20 V, V_{GS} = 0 V, f = 1MHz		901	1260	
C _{oss}	Output Capacitance	1		251	350	pF
C _{rss}	Reverse Transfer Capacitance	1		16	25	
Rg	Gate Resistance		0.1	0.6	1.8	Ω
SWITCHING	CHARACTERISTICS					
td _(on)	Turn – On Delay Time	$V_{DD} = 20 V, I_D = 10 A,$		6.4	13	ns
t _r	Rise Time	$V_{ m GS}$ = 10 V, $ m R_{ m GEN}$ = 6 Ω		1.8	10	
t _{D(off)}	Turn – Off Delay Time	1		17	31	
t _f	Fall Time	1		1.8	10	
Qg	Total Gate Charge	V _{GS} = 0V to 10 V		14	20	nC
Qg	Total Gate Charge	V _{GS} = 0V to 4.5 V		6.4	9.0	
Q _{gs}	Total Gate Charge	V _{DD} = 20 V, i _D = 10 A		2.4	3.7]
Q _{gd}	Gate to Source Charge			1.8	2.5	
DRAIN-SOL	IRCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2 A (Note 2)		0.7	1.2	V

V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2 A (Note 2)	0.7	1.2	V
		V _{GS} = 0 V, I _S = 10 A (Note 2)	0.8	1.2	
t _{rr}	Reverse Recovery Time	I _F = 10 A, di/dt = 100 A/µs	23	37	ns
Q _{rr}	Reverse Recovery Charge		6.7	14	nC

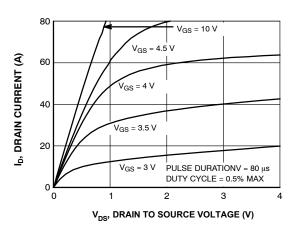
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

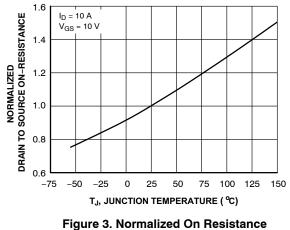
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. Pulsed I_D limited by junction temperature, td<= 100 μ S, please refer to SOA curve for more details.







vs. Junction Temperature



b) 145°C/W when mounted on a minimum pad of 2 oz copper.

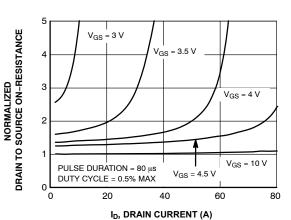
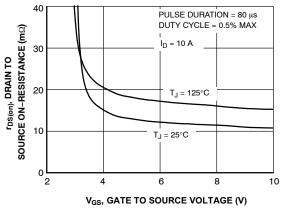


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage





TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted

TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted (continued)

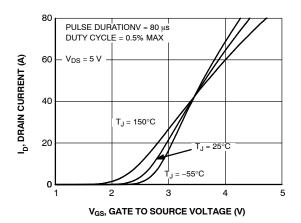


Figure 5. Transfer Characteristics

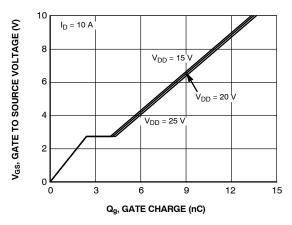


Figure 7. Gate Charge Characteristics

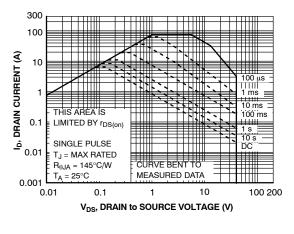


Figure 9. Forward Bias Safe Operating Area

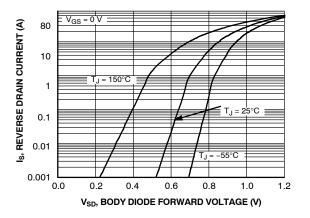


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

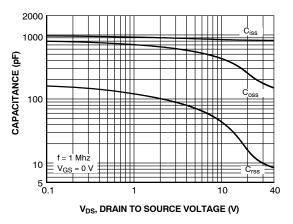


Figure 8. Capacitance vs. Drain to Source Voltage

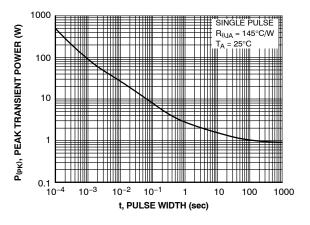


Figure 10. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted (continued)

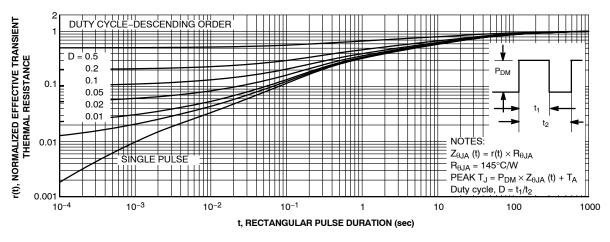


Figure 11. Single Pulse Junction-to-Ambient Transient Thermal Response Curve

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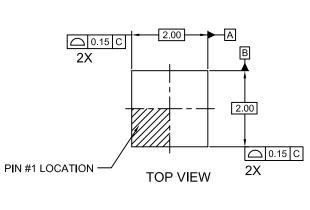
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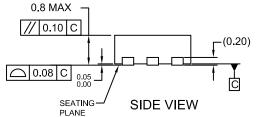
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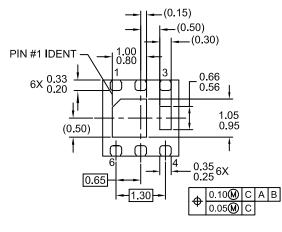
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Allowed in this Area





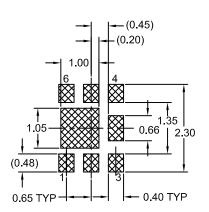


BOTTOM VIEW

NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-229 DATED AUG/2003
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER
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RECOMMENDED LAND PATTERN OPT 2

RECOMMENDED LAND PATTERN OPT 1

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